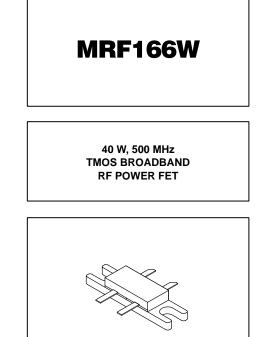
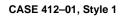
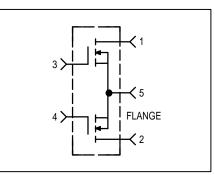
# The RF MOSFET Line Power Field Effect Transistor N-Channel Enhancement-Mode MOSFET

Designed primarily for wideband large-signal output and driver stages to 500 MHz.

- Push–Pull Configuration Reduces Even Numbered Harmonics
- Typical Performance at 400 MHz, 28 Vdc Output Power = 40 Watts Gain = 13 dB Efficiency = 50%
- Typical Performance at 175 MHz, 28 Vdc Output Power = 40 Watts Gain = 17 dB Efficiency = 60%
- Excellent Thermal Stability, Ideally Suited for Class A Operation
- Facilitates Manual Gain Control, ALC and Modulation Techniques
- 100% Tested for Load Mismatch at All Phase Angles with 30:1 VSWR
- Low C<sub>rss</sub> 4.5 pF @ V<sub>DS</sub> = 28 Volts
- Circuit board photomaster available upon request by contacting RF Tactical Marketing in Phoenix, AZ.







#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-Gate Voltage	V <sub>DSS</sub>	65	Vdc
Drain–Gate Voltage ( $R_{GS}$ = 1.0 M $\Omega$ )	VDGR	65	Vdc
Gate-Source Voltage	V <sub>GS</sub>	± 40	Adc
Drain Current — Continuous	۱ <sub>D</sub>	8.0	ADC
Total Device Dissipation @ T <sub>C</sub> = 25°C Derate above 25°C	PD	175 1.0	Watts °C/W
Storage Temperature Range	T <sub>stg</sub>	-65 to +150	°C
Operating Junction Temperature	Тј	200	°C

Thermal Resistance — Junction to Case $R_{\theta JC}$ 1.0°C/W

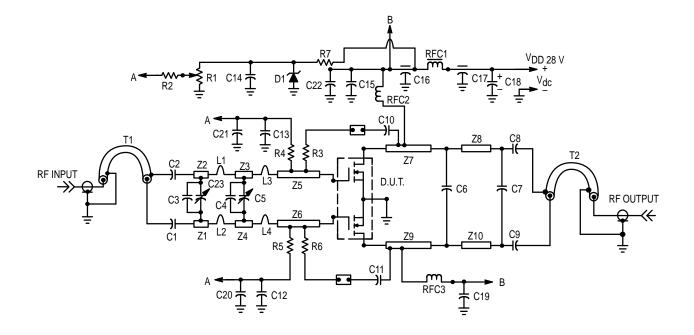
NOTE: Handling and Packaging — MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.

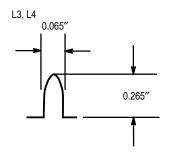


### ELECTRICAL CHARACTERISTICS (T<sub>C</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS (1)					
Drain–Source Breakdown Voltage ( $V_{GS} = 0 \text{ Vdc}, I_D = 5.0 \text{ mA}$ )	V <sub>(BR)</sub> DSS	65	_	_	Vdc
Zero Gate Voltage Drain Current (V <sub>DS</sub> = 28 Vdc, V <sub>GS</sub> = 0 Vdc)	IDSS	_	_	1.0	mA
Gate-Source Leakage Current (V <sub>GS</sub> = 40 Vdc, V <sub>DS</sub> = 0 Vdc)	IGSS	_	_	1.0	μΑ
ON CHARACTERISTICS (1)					
Gate Threshold Voltage $(V_{DS}=10 \text{ Vdc}, I_D=25 \text{ mA})$	VGS(th)	1.0	3.0	6.0	Vdc
Forward Transconductance $(V_{DS}=10 \text{ Vdc}, I_{D}=1.5 \text{ A})$	9fs	600	800	_	mS
DYNAMIC CHARACTERISTICS (1)					
Input Capacitance ( $V_{DS} = 28 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz}$ )	C <sub>iss</sub>	_	30	_	pF
Output Capacitance (V <sub>DS</sub> = 28 Vdc, V <sub>GS</sub> = 0 Vdc, f = 1.0 MHz)	C <sub>OSS</sub>	_	35	_	pF
Reverse Transfer Capacitance ( $V_{DS} = 28 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz}$ )	C <sub>rss</sub>	_	4.5	_	pF
FUNCTIONAL CHARACTERISTICS (2)					
Common Source Power Gain $(V_{DD} = 28 \text{ Vdc}, P_{out} = 40 \text{ W}, f = 400 \text{ MHz}, I_{DG} = 100 \text{ mA})$	G <sub>ps</sub>	11	13	_	dB
Drain Efficiency $(V_{DD} = 28 \text{ Vdc}, P_{out} = 40 \text{ W}, f = 400 \text{ MHz}, I_{DG} = 100 \text{ mA})$	η	45	50	_	%
Electrical Ruggedness ( $V_{DD}$ = 28 Vdc, $P_{out}$ = 40 W, f = 400 MHz, $I_{DG}$ = 100 mA) Load VSWR = 30:1, All phase angles at frequency of test	Ψ	No E	Degradation in	Output Pow	er

Each transistor chip measured separately.
Both transistor chips operating in a push-pull amplifier.





L1, L2 0.116″	
	0.455″
	1

C1, C2, C8, C9,	270 pF, Chip Cap	RFC1	Ferroxcube VK–200–19/4B
C12, C13, C15		RFC2, RFC3	10T, ID = 1/4", 18 AWG
C3	5.6 pF, Chip Cap	R1	10 kΩ, 10T
C4	20 pF, Chip Cap	R2	9.2 kΩ, 1/2 W
C5	0 – 20 pF, Johanson*	R3, R6	330 Ω, 1.0 W
C6	8.2 pF, Chip Cap	R4 R5	520 Ω, 1/4 W
C7	15 pF, Chip Cap	R7	1.5 kΩ, 1/2 W
C10, C11, C14, C19,	0.01 μF	T1, T2	Balun 2.0", 50 $\Omega$ Semi–Rigid Coax
C20, C21, C22		Z1, Z2	0.120 x 0.467″
C16, C17	680 pF, Feedthru	Z3, Z4	0.120 x 0.55″ *
C18	10 μF, 50 V	Z5, Z6	0.120 x 0.49″
C23	0 – 10 pF, Johanson*	Z7, Z9	0.120 x 0.85″
D1	IN5343 – Motorola Zener	Z8, Z10	0.120 x 0.6" for C6
L1, L2	Hair Pin Inductor #18 AWG,		
	0.065 W x 0.265 H	* C4, C5 Center of Z3 and Z4	
L3, L4	Hair Pin Inductor #18 AWG,	Board Material – Teflon $^{\textcircled{R}}$ Fiberglass	
	0.116 W x 0.445 H	Dielectric Thickness = 0.030", $\varepsilon_r$ = 2.55 Copper Clad, 2.0 oz. Copper	

## Figure 1. MRF166 400 MHz Test Circuit Schematic

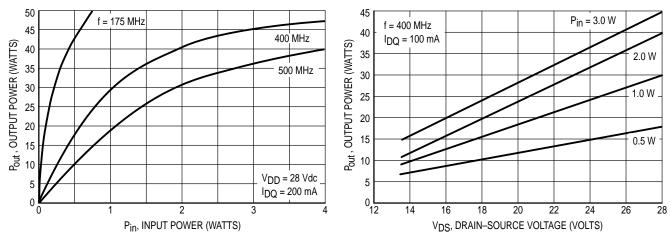


Figure 2. Output Power versus Input Power

Figure 3. Output Power versus Voltage

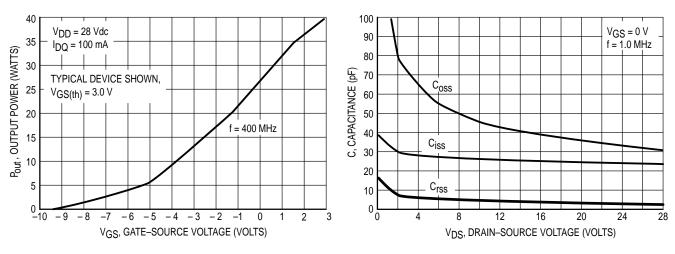
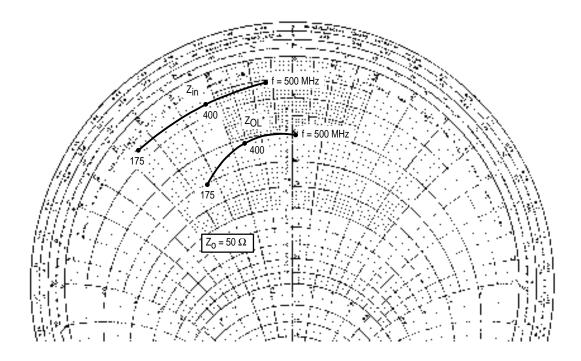


Figure 4. Output Power versus Gate Voltage

Figure 5. Capacitance versus Voltage



 $V_{DD}$  = 28 Vdc, I<sub>DQ</sub> = 100 mA, P<sub>out</sub> = 40 W

f MHz	Z <sub>in</sub> Ohms	Z <sub>OL</sub> * Ohms
175	3.7 – j 22.4	15.2 – j 16.6
400	3.6 – j 10.99	10.3 – j 7.99
500	2.6 – j 3.2	10.2 + j 0.5

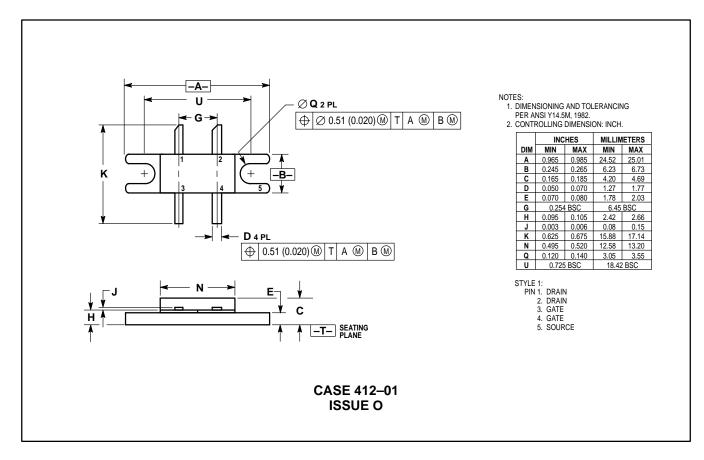
Table 1. Input and Output Impedances

 $Z_{OL}^*$  = Conjugate of the optimum load impedance into which the device output operates at a given output power, voltage and frequency.

NOTE: Input and output impedance values given are measured from gate to gate and drain to drain respectively.

### Figure 6. Series Equivalent Input/Output Impedance

### PACKAGE DIMENSIONS



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#### How to reach us:

USA/EUROPE: Motorola Literature Distribution; P.O. Box 20912; Phoenix, Arizona 85036. 1–800–441–2447 JAPAN: Nippon Motorola Ltd.; Tatsumi–SPD–JLDC, Toshikatsu Otsuki, 6F Seibu–Butsuryu–Center, 3–14–2 Tatsumi Koto–Ku, Tokyo 135, Japan. 03–3521–8315

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HONG KONG: Motorola Semiconductors H.K. Ltd.; 8B Tai Ping Industrial Park, 51 Ting Kok Road, Tai Po, N.T., Hong Kong. 852–26629298

